



SMF13N50

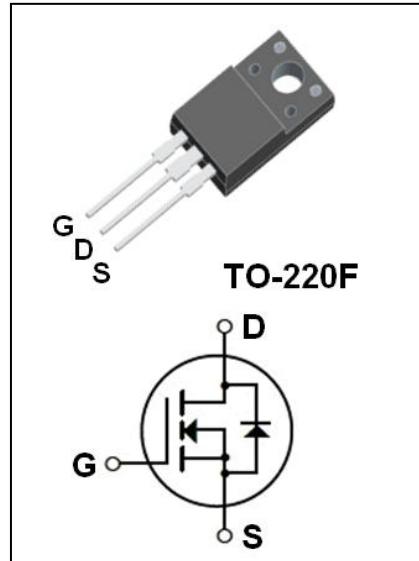
500V N-Channel MOSFET

● Features:

- 13.0A, 500V, $R_{DS(on)(Typ)} = 0.42\Omega$ @ $V_{GS} = 10V$
- Low Gate Charge
- Low C_{rss}
- 100% Avalanche Tested
- Fast Switching
- Improved dv/dt Capability

● Application:

- High Frequency Switching Mode Power Supply
- Active Power Factor Correction



Absolute Maximum Ratings ($T_c = 25^\circ C$ unless otherwise noted)

Symbol	Parameter	Value	Unit	
V_{DSS}	Drain-Source Voltage	500	V	
I_D	Drain Current - Continuous ($T_c = 25^\circ C$)	13.0*	A	
	- Continuous ($T_c = 100^\circ C$)	8.0*	A	
I_{DM}	Drain Current - Pulsed	(Note 1)	52*	A
V_{GSS}	Gate-Source Voltage	± 30	V	
E_{AS}	Single Pulsed Avalanche Energy	(Note 2)	845	mJ
I_{AR}	Avalanche Current	(Note 1)	13.0	A
E_{AR}	Repetitive Avalanche Energy	(Note 1)	19.5	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	4.5	V/ns
P_D	Power Dissipation ($T_c = 25^\circ C$)	50	W	
	-Derate above $25^\circ C$	0.4	W/ $^\circ C$	
T_j	Operating Junction Temperature	150	$^\circ C$	
T_{stg}	Storage Temperature Range	-55 to +150	$^\circ C$	

* Drain Current Limited by Maximum Junction Temperature.

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	2.58	$^\circ C / W$
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	62.5	$^\circ C / W$

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Electrical Characteristics($T_c=25^\circ\text{C}$ unless otherwise noted)

Symbol	Parameter	Test Conditions	Min	Typ	Max	Unit
Off Characteristics						
BV_{DSS}	Drain-source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{D}}=250\mu\text{A}$	500	--	--	V
$\Delta \text{BV}_{\text{DSS}} / \Delta T_J$	Breakdown Voltage Temperature Coefficient	$I_{\text{D}}=250\mu\text{A}$ (Referenced to 25°C)	--	0.63	--	$\text{V}/^\circ\text{C}$
$I_{\text{DS}}^{\text{SS}}$	Zero Gate Voltage Drain Current	$V_{\text{DS}}=500\text{V}, V_{\text{GS}}=0\text{V}$	--	--	1	μA
		$V_{\text{DS}}=400\text{V}, T_c=125^\circ\text{C}$	--	--	10	μA
I_{GSSF}	Gate-Body Leakage Current,Forward	$V_{\text{GS}}=+30\text{V}, V_{\text{DS}}=0\text{V}$	--	--	100	nA
I_{GSSR}	Gate-Body Leakage Current,Reverse	$V_{\text{GS}}=-30\text{V}, V_{\text{DS}}=0\text{V}$	--	--	-100	nA
On Characteristics						
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{D}}=250\mu\text{A}$	2.0	--	4.0	V
$R_{\text{DS(on)}}$	Static Drain-Source On-Resistance	$V_{\text{GS}}=10\text{ V}, I_{\text{D}}=6.5\text{A}$	--	0.42	0.52	Ω
g_{FS}	Forward Transconductance	$V_{\text{DS}}=40\text{ V}, I_{\text{D}}=6.5\text{A}$ (Note4)	--	8	--	S
Dynamic Characteristics						
C_{iss}	Input Capacitance	$V_{\text{DS}}=25\text{V}, V_{\text{GS}}=0\text{V}, f=1.0\text{MHz}$	--	1560	--	pF
C_{oss}	Output Capacitance		--	210	--	pF
C_{rss}	Reverse Transfer Capacitance		--	25	--	pF
Switching Characteristics						
$t_{\text{d(on)}}$	Turn-On Delay Time	$V_{\text{DD}} = 250\text{ V}, I_{\text{D}} = 13.0\text{A}, R_{\text{G}} = 25\Omega$ (Note4,5)	--	90	--	ns
t_r	Turn-On Rise Time		--	160	--	ns
$t_{\text{d(off)}}$	Turn-Off Delay Time		--	150	--	ns
t_f	Turn-Off Fall Time		--	60	--	ns
Q_g	Total Gate Charge	$V_{\text{DS}} = 400\text{ V}, I_{\text{D}} = 13.0\text{ A}, V_{\text{GS}} = 10\text{ V}$ (Note4,5)	--	37	--	nC
Q_{gs}	Gate-Source Charge		--	10.9	--	nC
Q_{gd}	Gate-Drain Charge		--	17.2	--	nC
Drain-Source Diode Characteristics and Maximum Ratings						
I_s	Maximum Continuous Drain-Source Diode Forward Current	--	--	13.0	--	A
I_{SM}	Maximum Pulsed Drain-Source Diode Forward Current	--	--	52	--	A
V_{SD}	Drain-Source Diode Forward Voltage	$V_{\text{GS}} = 0\text{V}, I_s = 13.0\text{A}$	--	--	1.4	V
t_{rr}	Reverse Recovery Time	$V_{\text{GS}} = 0\text{V}, I_s = 13.0\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$ (Note4)	--	410	--	ns
Q_{rr}	Reverse Recovery Charge		--	4.5	--	μC

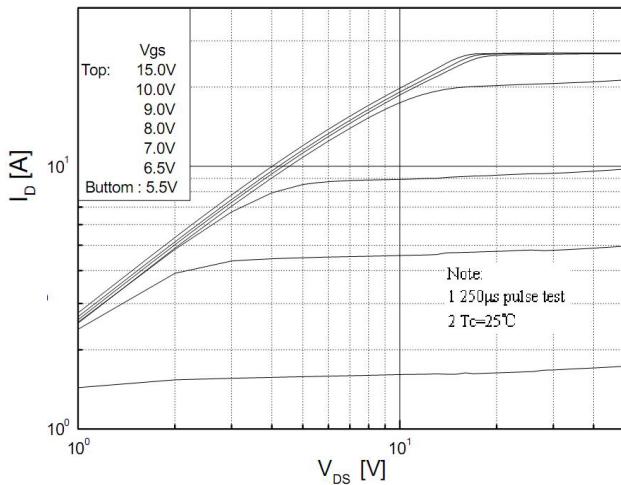
Notes:

- Repetitive Rating:Pulse Width Limited by Maximum Junction Temperature.
- $L = 9\text{mH}, I_{\text{AS}} = 13.0\text{A}, V_{\text{DD}} = 50\text{V}, R_{\text{G}} = 25\Omega$, Starting $T_J = 25^\circ\text{C}$.
- $I_{\text{SD}} \leq 13.0\text{A}, di/dt \leq 200\text{A}/\mu\text{s}, V_{\text{DD}} \leq \text{BV}_{\text{DSS}}$, Starting $T_J = 25^\circ\text{C}$.
- Pulse Test : Pulse Width $\leq 300\text{ }\mu\text{s}$, Duty Cycles $\leq 2\%$.
- Essentially Independent of Operating Temperature.

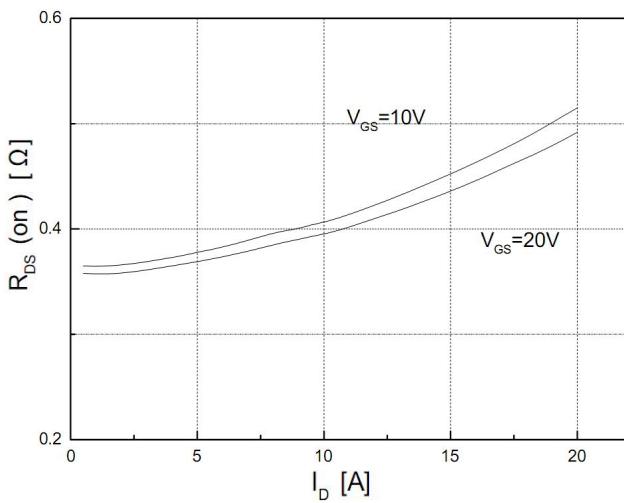
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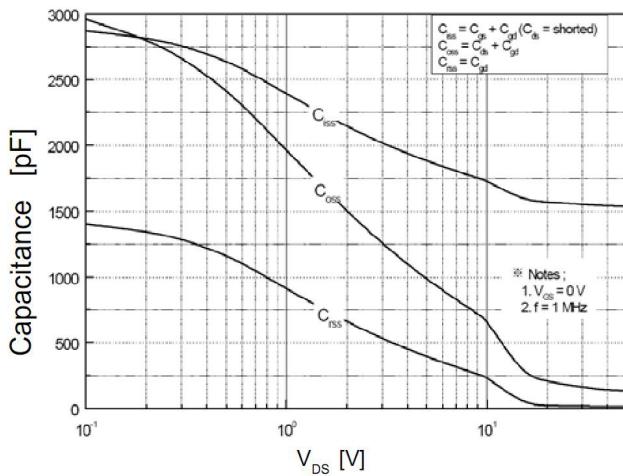
On-Region Characteristics



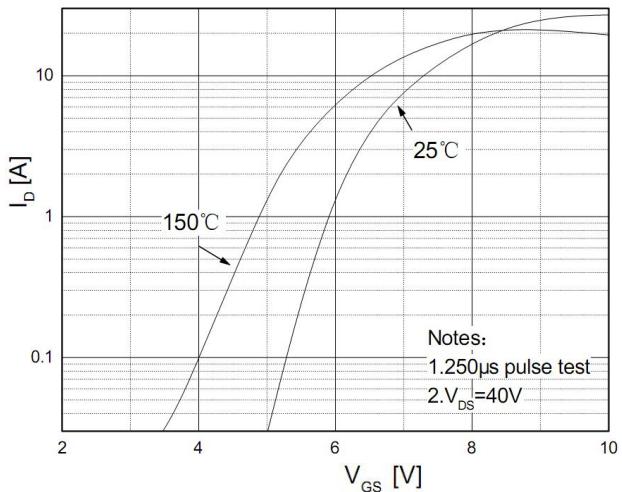
On-Resistance Variation vs.
Drain Current and Gate Voltage



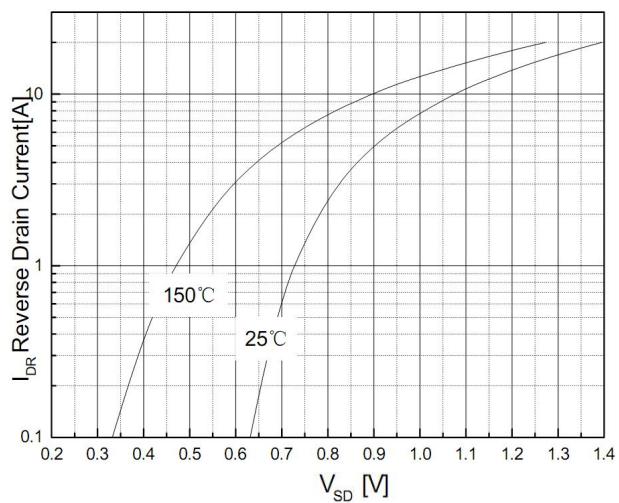
Capacitance Characteristics



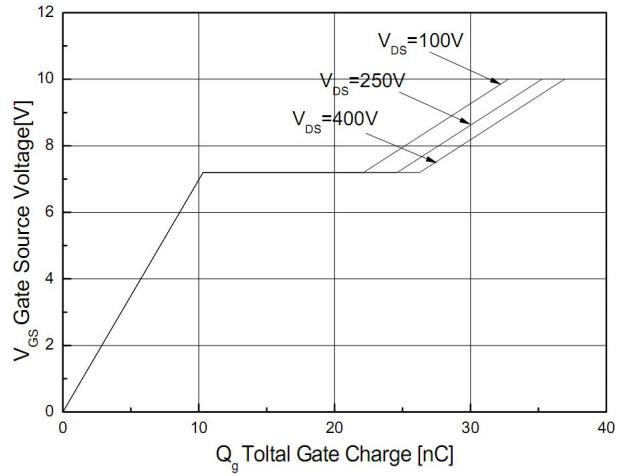
Transfer Characteristics



Body Diode Forward Voltage Variation
vs. Source Current and Temperature



Gate Charge Characteristics

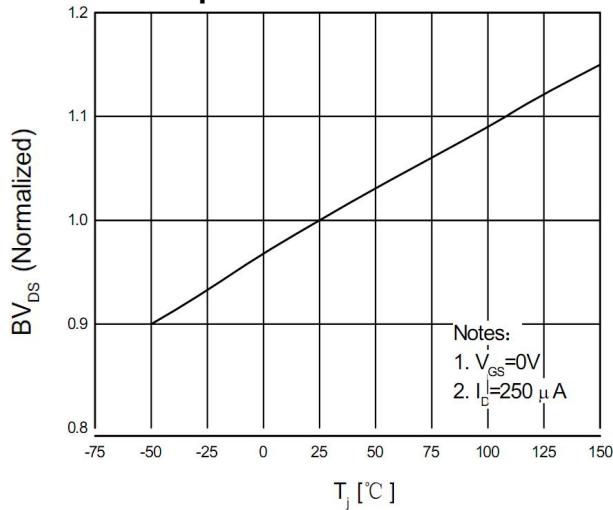




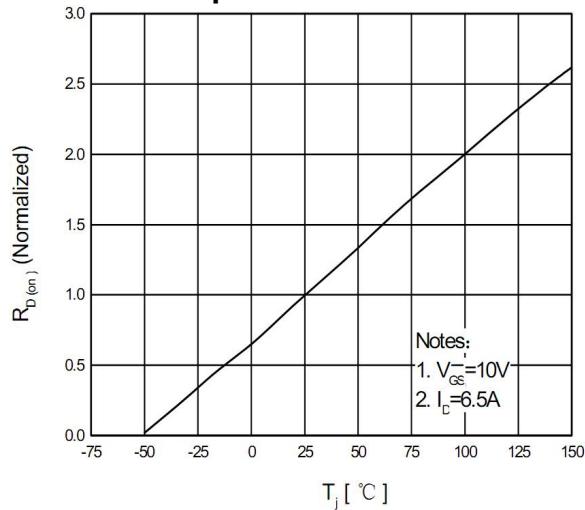
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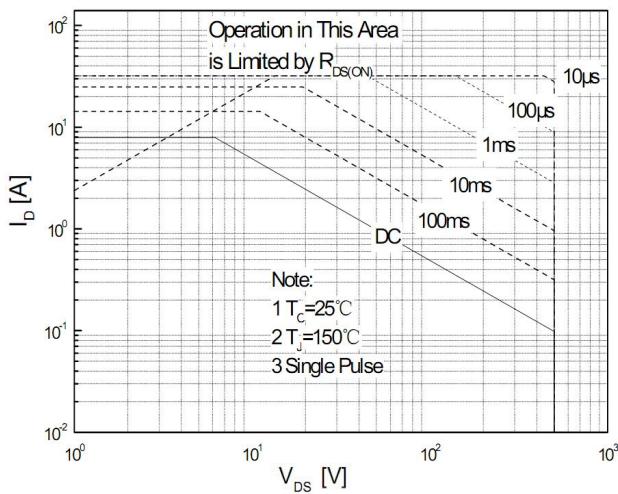
Breakdown Voltage Variation vs. Temperature



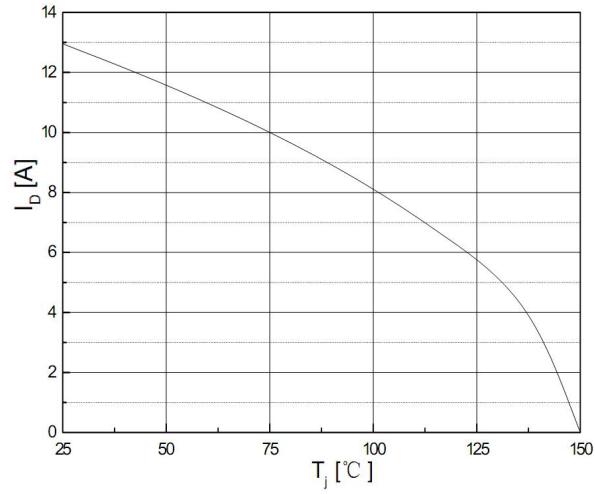
On-Resistance Variation vs. Temperature



Maximum Safe Operating Area



Maximum Drain Current Vs. Case Temperature



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TO-220F Package Dimensions

UNIT: mm

SYMBOL	min	nom	max	SYMBOL	min	nom	max
A	9.80		10.60	D		2.54	
A1		7.00		D1	1.15		1.55
A2	2.90		3.40	D2	0.60		1.00
A3	9.10		9.90	D3	0.20		0.50
B1	15.40		16.40	E	2.24		2.84
B2	4.35		4.95	E1		0.70	
B3	6.00		7.40	E2		$1.0 \times 45^\circ$	
C	3.00		3.70	E3	0.35		0.65
C1	15.00		17.00	E4	2.30		3.30
C2	8.80		10.80	α (度)		30°	

